

Search Notes

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Leon J. Harper

Applicant(s)/Patent under
Reexamination

KAWAI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
707	200,104.1, 1,10,8,6,5, 4	3/2/2006	LJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR